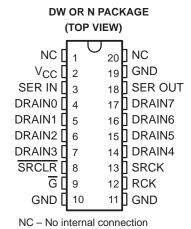
- Low r_{DS(on)} . . . 5 Ω Typical
- Avalanche Energy . . . 30 mJ
- Eight Power DMOS-Transistor Outputs of 150-mA Continuous Current
- 500-mA Typical Current-Limiting Capability
- Output Clamp Voltage . . . 50 V
- Devices Are Cascadable
- Low Power Consumption

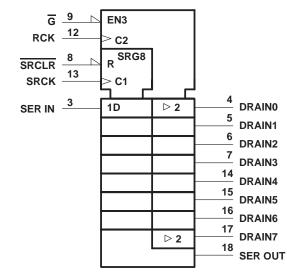
description

The TPIC6B595 is a monolithic, high-voltage, medium-current power 8-bit shift register designed for use in systems that require relatively high load power. The device contains a built-in voltage clamp on the outputs for inductive transient protection. Power driver applications include relays, solenoids, and other medium-current or high-voltage loads.

This device contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Data transfers through both the shift and storage registers on the rising edge of the shift-register clock (SRCK) and the register clock (RCK), respectively. The storage register transfers data to the output buffer when shiftregister clear (SRCLR) is high. When SRCLR is low, the input shift register is cleared. When output enable (\overline{G}) is held high, all data in the output buffers is held low and all drain outputs are off. When \overline{G} is held low, data from the storage register is transparent to the output buffers. When data in the output buffers is low, the DMOS-transistor outputs are off. When data is high, the DMOStransistor outputs have sink-current capability. The serial output (SER OUT) allows for cascading of the data from the shift register to additional devices.



logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

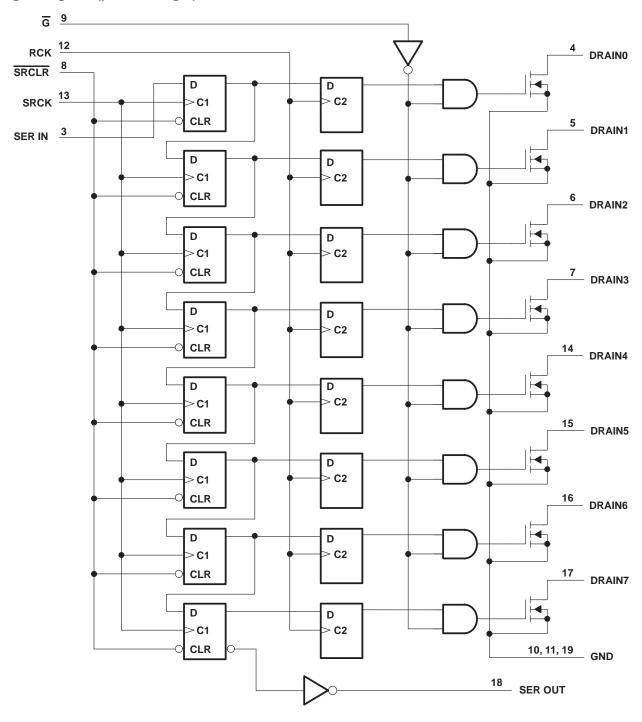
Outputs are low-side, open-drain DMOS transistors with output ratings of 50 V and 150-mA continuous sink-current capability. Each output provides a 500-mA typical current limit at $T_C = 25$ °C. The current limit decreases as the junction temperature increases for additional device protection.

The TPIC6B595 is characterized for operation over the operating case temperature range of −40°C to 125°C.

TPIC6B595 POWER LOGIC 8-BIT SHIFT REGISTER

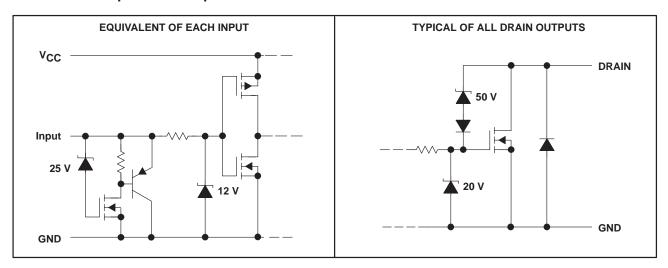
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logic diagram (positive logic)





schematic of inputs and outputs



absolute maximum ratings over recommended operating case temperature range (unless otherwise noted) †

Logic supply voltage, V _{CC} (see Note 1)	7 V
Logic input voltage range, V _I	
Power DMOS drain-to-source voltage, V _{DS} (see Note 2)	50 V
Continuous source-to-drain diode anode current	500 mA
Pulsed source-to-drain diode anode current (see Note 3)	1 A
Pulsed drain current, each output, all outputs on, I _D , T _C = 25°C (see Note 3)	500 mA
Continuous drain current, each output, all outputs on, ID, TC = 25°C	150 mA
Peak drain current single output, I _{DM} ,T _C = 25°C (see Note 3)	
Single-pulse avalanche energy, E _{AS} (see Figure 4)	30 mJ
Avalanche current, I _{AS} (see Note 4)	500 mA
Continuous total dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, T _J	–40°C to 150°C
Operating case temperature range, T _C	40°C to 125°C
Storage temperature range	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to GND.

- 2. Each power DMOS source is internally connected to GND.
- 3. Pulse duration \leq 100 μ s and duty cycle \leq 2%.
- 4. DRAIN supply voltage = 15 V, starting junction temperature (T_{JS}) = 25°C, L = 200 mH, I_{AS} = 0.5 A (see Figure 4).

DISSIPATION RATING TABLE

PACKAGE	$T_C \le 25^{\circ}C$ POWER RATING	DERATING FACTOR ABOVE T _C = 25°C	T _C = 125°C POWER RATING		
DW	1389 mW	11.1 mW/°C	278 mW		
N	1050 mW	10.5 mW/°C	263 mW		



TPIC6B595 **POWER LOGIC 8-BIT SHIFT REGISTER**

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recommended operating conditions

	MIN	MAX	UNIT
Logic supply voltage, V _{CC}	4.5	5.5	V
High-level input voltage, VIH	0.85 V _{CC}		V
Low-level input voltage, V _{IL}		0.15 V _{CC}	V
Pulsed drain output current, T _C = 25°C, V _{CC} = 5 V (see Notes 3 and 5)	-500	500	mA
Setup time, SER IN high before SRCK↑, t _{SU} (see Figure 2)	20		ns
Hold time, SER IN high after SRCK↑, th (see Figure 2)	20		ns
Pulse duration, t _W (see Figure 2)	40		ns
Operating case temperature, T _C	-40	125	°C

electrical characteristics, V_{CC} = 5 V, T_{C} = 25°C (unless otherwise noted)

	PARAMETER	TEST CONI	DITIONS	MIN	TYP	MAX	UNIT
V(BR)DSX	Drain-to-source breakdown voltage	I _D = 1 mA		50			V
V _{SD}	Source-to-drain diode forward voltage	I _F = 100 mA			0.85	1	V
Vou	High-level output voltage,	$I_{OH} = -20 \mu\text{A}, \ \ V_{CC} = 4.5 \text{V}$,	4.4	4.49		V
VOH	SER OUT	$I_{OH} = -4 \text{ mA}, V_{CC} = 4.5 \text{ V}$,	4	4.2] ' [
\/o.	Low-level output voltage,	$I_{OL} = 20 \mu\text{A}, V_{CC} = 4.5 \text{V}$	•		0.005	0.1	V
VOL	SER OUT	$I_{OL} = 4 \text{ mA}, V_{CC} = 4.5 \text{ V}$,		0.3	0.5	
lн	High-level input current	$V_{CC} = 5.5 \text{ V}, V_{I} = V_{CC}$				1	μΑ
I _I L	Low-level input current	$V_{CC} = 5.5 \text{ V}, V_{I} = 0$				-1	μΑ
laa	Logic supply current	I Vcc = 5.5 V	All outputs off		20	100	μΑ
lcc			All outputs on		150	300	
ICC(FRQ)	Logic supply current at frequency	fSRCK = 5 MHzC _L = 30 pF, All outputs off,	See Figures 2 and 6		0.4	5	mA
I _N	Nominal current	$V_{DS(on)} = 0.5 \text{ V},$ $I_{N} = I_{D},$ $T_{C} = 85^{\circ}C$	See Notes 5, 6, and 7		90		mA
lnov	Off-state drain current	$V_{DS} = 40 \text{ V}, V_{CC} = 5.5 \text{ V}$	•		0.1	5	
IDSX	On-state drain current	$V_{DS} = 40 \text{ V}, V_{CC} = 5.5 \text{ V}$, T _C = 125°C		0.15	8	μΑ
		$I_D = 100 \text{ mA}, V_{CC} = 4.5 \text{ V}$			4.2	5.7	
rDS(on)	Static drain-source on-state resistance	$I_D = 100 \text{ mA}, T_C = 125^{\circ}\text{C}, \\ V_{CC} = 4.5 \text{ V}$	See Notes 5 and 6 and Figures 7 and 8		6.8	9.5	Ω
		$I_D = 350 \text{ mA}, V_{CC} = 4.5 \text{ V}$			5.5	8	

NOTES: 3. Pulse duration \leq 100 μ s and duty cycle \leq 2%.

- Technique should limit T_J T_C to 10°C maximum.
 These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.
- 7. Nominal current is defined for a consistent comparison between devices from different sources. It is the current that produces a voltage drop of 0.5 V at $T_C = 85^{\circ}C$.

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switching characteristics, V_{CC} = 5 V, T_{C} = 25°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH	Propagation delay time, low-to-high-level output from G			150		ns
tPHL	Propagation delay time, high-to-low-level output from \overline{G}	$C_L = 30 \text{ pF}, \qquad I_D = 100 \text{ mA},$		90		ns
t _r	Rise time, drain output	See Figures 1, 2, and 9		200		ns
t _f	Fall time, drain output			200		ns
ta	Reverse-recovery-current rise time	I _F = 100 mA, di/dt = 20 A/μs,		100		ns
t _{rr}	Reverse-recovery time	See Notes 5 and 6 and Figure 3		300		115

NOTES: 5. Technique should limit $T_J - T_C$ to 10°C maximum.

thermal resistance

PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
R _{θJA} Thermal resistance, junction-to-ambient	DW package	All 8 outputs with equal power		90	°C/W
	N package	All 6 outputs with equal power		95	

PARAMETER MEASUREMENT INFORMATION 5 V 24 V SRCK ID. SRCLR 5 V $R_L = 235 \Omega$ 13 0 V SRCK 4-7, DUT Output **SER IN** 14-17 Word 0 V DRAIN SER IN Generator (see Note A) 12 **RCK** $C_L = 30 pF$ **RCK** (see Note B) 9 G SRCLR 0 V 24 V 10, 11, 19 DRAIN1 0.5 V **VOLTAGE WAVEFORMS TEST CIRCUIT**

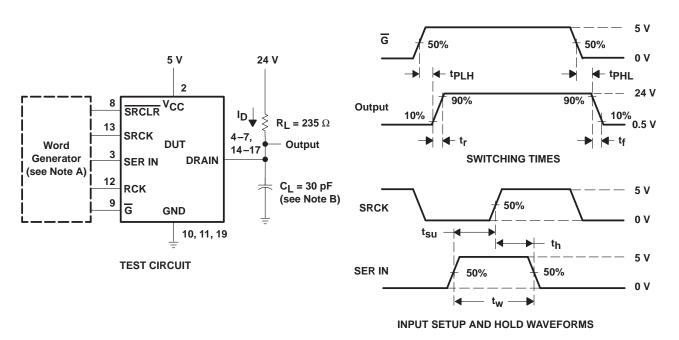
NOTES: A. The word generator has the following characteristics: $t_{\Gamma} \le 10$ ns, $t_{W} = 300$ ns, pulsed repetition rate (PRR) = 5 kHz, $Z_{O} = 50 \ \Omega$.

B. C_L includes probe and jig capacitance.

Figure 1. Resistive-Load Test Circuit and Voltage Waveforms

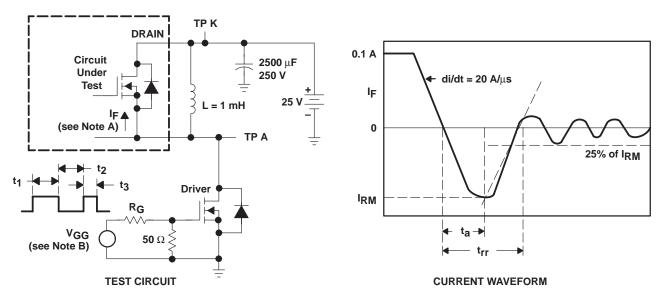
^{6.} These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The word generator has the following characteristics: $t_{\Gamma} \le 10$ ns, $t_{W} = 300$ ns, pulsed repetition rate (PRR) = 5 kHz, $Z_{O} = 50 \ \Omega$.
 - B. CL includes probe and jig capacitance.

Figure 2. Test Circuit, Switching Times, and Voltage Waveforms

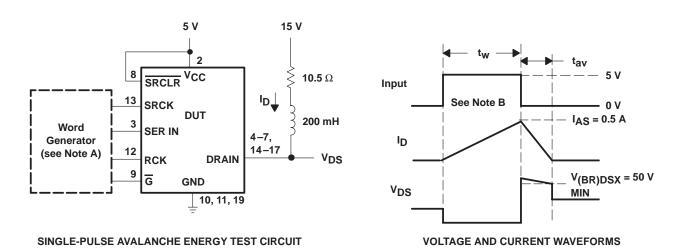


- NOTES: A. The DRAIN terminal under test is connected to the TP K test point. All other terminals are connected together and connected to the TP A test point.
 - B. The V_{GG} amplitude and R_G are adjusted for di/dt = 20 A/ μ s. A V_{GG} double-pulse train is used to set I_F = 0.1 A, where t₁ = 10 μ s, t₂ = 7 μ s, and t₃ = 3 μ s.

Figure 3. Reverse-Recovery-Current Test Circuit and Waveforms of Source-to-Drain Diode



PARAMETER MEASUREMENT INFORMATION

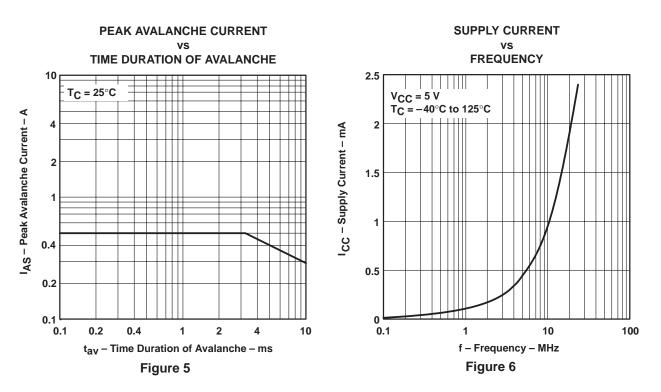


NOTES: A. The word generator has the following characteristics: $t_f \le 10$ ns, $t_f \le 10$ ns, $t_O = 50$ Ω .

B. Input pulse duration, t_W , is increased until peak current $I_{AS} = 0.5 \text{ A}$. Energy test level is defined as $E_{AS} = I_{AS} \times V_{(BR)DSX} \times t_{aV}/2 = 30 \text{ mJ}$.

Figure 4. Single-Pulse Avalanche Energy Test Circuit and Waveforms

TYPICAL CHARACTERISTICS





TYPICAL CHARACTERISTICS

DRAIN-TO-SOURCE ON-STATE RESISTANCE **DRAIN CURRENT** $^{ m LDS(on)}$ – Drain-to-Source On-State Resistance – $^{ m CO}$ 18 V_{CC} = 5 V See Note A 16 14 T_C = 125°C 12 10 8 6 T_C = 25°C T_C = -40°C 0 0 100 200 300 400 500 600 700 ID - Drain Current - mA

Figure 7

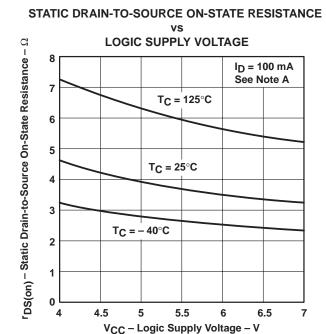


Figure 8

SWITCHING TIME vs CASE TEMPERATURE

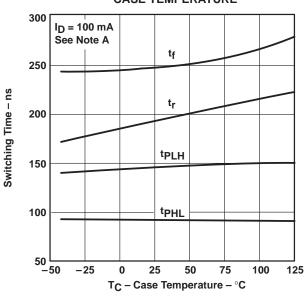


Figure 9

NOTE C: Technique should limit $T_J - T_C$ to 10°C maximum.



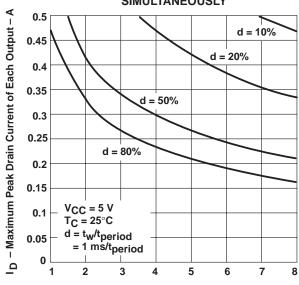
THERMAL INFORMATION

MAXIMUM CONTINUOUS DRAIN CURRENT OF EACH OUTPUT NUMBER OF OUTPUTS CONDUCTING **SIMULTANEOUSLY** 0.45 $V_{CC} = 5 V$ 0.4 0.35 0.3 0.25 $T_C = 25^{\circ}C$ 0.2 0.15 T_C = 100°C 0.1 T_C = 125°C 0.05 0 2 6 7 3 4 5 8

 Maximum Continuous Drain Current of Each Output - A N - Number of Outputs Conducting Simultaneously Figure 10

MAXIMUM PEAK DRAIN CURRENT OF EACH OUTPUT

NUMBER OF OUTPUTS CONDUCTING **SIMULTANEOUSLY**



N - Number of Outputs Conducting Simultaneously

Figure 11

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